-AIRCHILD

P-Channel 1.8V Specified PowerTrench[®] MOSFET

General Description

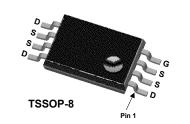
This P-Channel 1.8V specified MOSFET is a rugged gate version of Fairchild Semiconductor's advanced PowerTrench process. It has been optimized for power management applications with a wide range of gate drive voltage (1.8V - 8V).

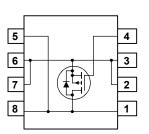
Applications

- Load switch
- Motor drive
- DC/DC conversion
- Power management

Features

- -9.2 A, -20 V. $R_{DS(ON)} = 0.012 \Omega @V_{GS} = -4.5 V$ $R_{DS(ON)} = 0.015 \Omega @V_{GS} = -2.5 V$ $R_{DS(ON)} = 0.0215 \Omega @V_{GS} = -1.8 V$
- Rds ratings for use with 1.8 V logic
- Low gate charge
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- Low profile TSSOP-8 package





Absolute Maximum Ratings T_A=25°C unless otherwise noted

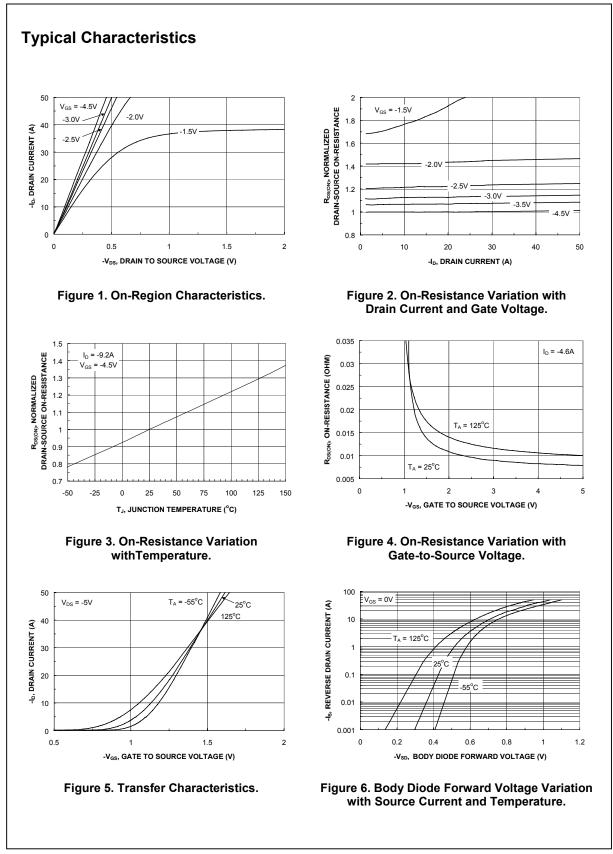
Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		-20	V
V _{GSS}	Gate-Source Voltage		±8	V
ID	Drain Current – Continuous	(Note 1)	-9.2	A
	- Pulsed		-50	
P _D	Power Dissipation	(Note 1a)	1.3	W
		(Note 1b)	0.6	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C
Therma	I Characteristics			
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	96	°C/W
		(Note 1b)	208	

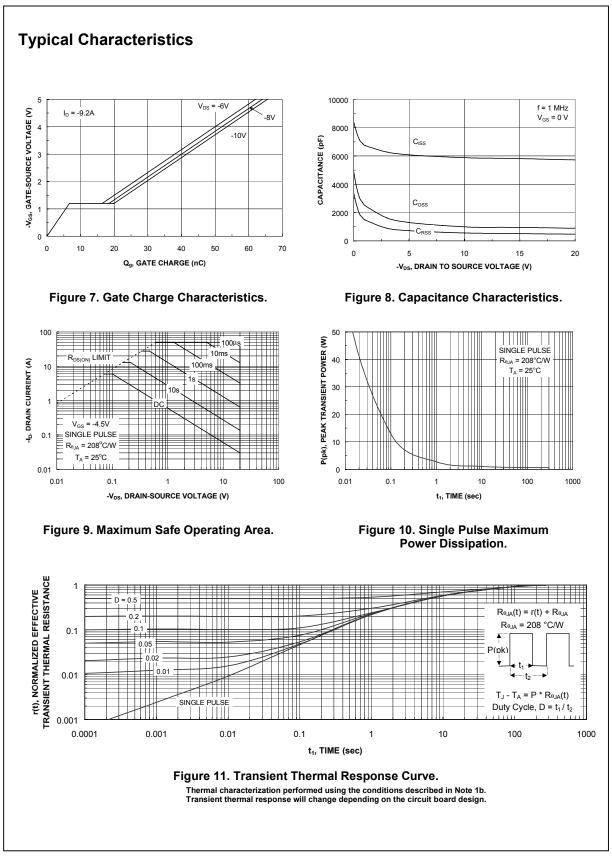
Package Marking and Ordering Information

-	Device Marking	Device	Reel Size	Tape width	Quantity
	254P	FDW254P	13"	12mm	3000 units

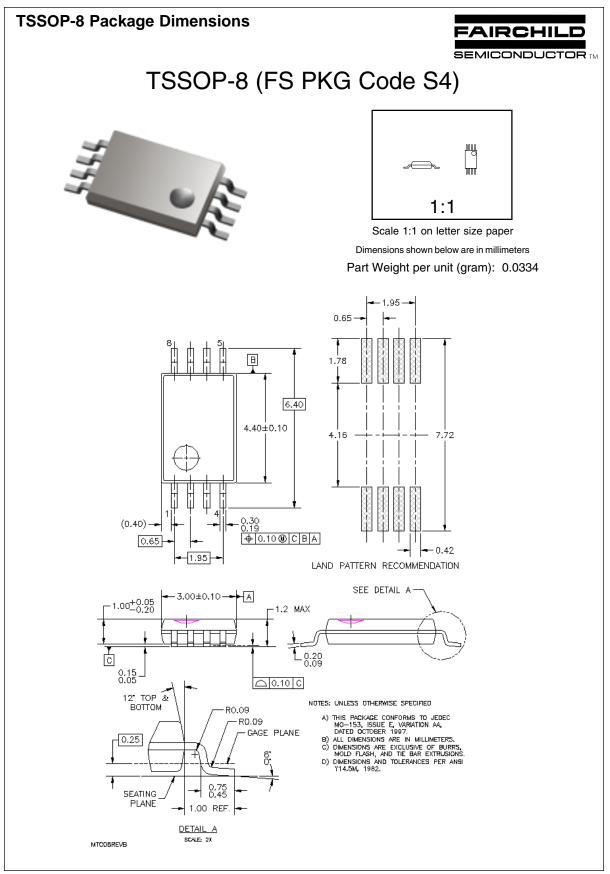
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CS Irce Breakdown Voltage Irce Breakdown Voltage Irce Breakdown Voltage Voltage Drain Current y Leakage, Forward y Leakage, Reverse CS (Note 2) shold Voltage Irce Coefficient In-Source tance	$\begin{array}{l} V_{GS} = 0 \ V, \ I_D = -250 \ \mu A \\ \\ I_D = -250 \ \mu A, \ Referenced \ to \ 25^\circ C \\ \\ V_{DS} = -16 \ V, \ V_{GS} = 0 \ V \\ \\ V_{GS} = -8 \ V, \ V_{DS} = 0 \ V \\ \\ V_{GS} = 8 \ V \ V_{DS} = 0 \ V \\ \\ \end{array}$	-20	-11	-1 -100 100	V mV/°C μA nA nA
Irce Breakdown Voltage n Voltage Temperature t Voltage Drain Current y Leakage, Forward y Leakage, Reverse CS (Note 2) shold Voltage shold Voltage ure Coefficient in–Source	$I_{D} = -250 \ \mu\text{A}, \text{ Referenced to } 25^{\circ}\text{C}$ $V_{DS} = -16 \ V, V_{GS} = 0 \ V$ $V_{GS} = -8 \ V, V_{DS} = 0 \ V$ $V_{GS} = 8 \ V V_{DS} = 0 \ V$ $V_{DS} = V_{GS}, I_{D} = -250 \ \mu\text{A}$			-100	mV/°C μA nA
t Voltage Drain Current y Leakage, Forward y Leakage, Reverse CS (Note 2) shold Voltage shold Voltage ure Coefficient in–Source	$V_{DS} = -16 V, V_{GS} = 0 V$ $V_{GS} = -8 V, V_{DS} = 0 V$ $V_{GS} = 8 V, V_{DS} = 0 V$ $V_{DS} = V_{GS}, I_D = -250 \ \mu A$	-0.4		-100	μA nA
y Leakage, Forward y Leakage, Reverse CS (Note 2) shold Voltage shold Voltage ure Coefficient in-Source	$V_{GS} = -8 V, V_{DS} = 0 V$ $V_{GS} = 8 V V_{DS} = 0 V$ $V_{DS} = V_{GS}, I_D = -250 \mu A$	-0.4	-0.6	-100	nA
y Leakage, Reverse CS (Note 2) shold Voltage shold Voltage ure Coefficient in–Source	V_{GS} = 8 V V_{DS} = 0 V V_{DS} = V_{GS} , I_D = -250 μ A	-0.4	-0.6		
CS (Note 2) shold Voltage shold Voltage ure Coefficient in-Source	V_{DS} = V_{GS} , I_D = -250 μ A	-0.4	-0.6	100	nA
shold Voltage shold Voltage ure Coefficient n–Source		-0.4	-0.6		
shold Voltage shold Voltage ure Coefficient n–Source		-0.4	-0.6		
ure Coefficient in–Source	I_D = -250 µA, Referenced to 25°C			-1.5	V
			2		mV/°C
	$ \begin{array}{c c} V_{GS} = -4.5 \text{ V}, & I_D = -9.2 \text{ A} \\ V_{GS} = -2.5 \text{ V}, & I_D = -7.9 \text{ A} \\ V_{GS} = -1.8 \text{ V}, & I_D = -6.5 \text{ A} \\ V_{GS} = -4.5 \text{ V}, I_D = -9.2 \text{ A}, T_J = 125^{\circ}\text{C} \end{array} $		9 11 14 12	12 15 21.5 18	mΩ
Drain Current	$V_{GS} = -4.5 V$, $V_{DS} = -5 V$	-50		10	Α
ransconductance	$V_{DS} = -5 V.$ $I_{D} = -9.2 A$		54		s
acitance	$V_{DS} = -10 V$, $V_{GS} = 0 V$, f = 1.0 MHz		5878		pF
pacitance			994		pF
ransfer Capacitance			559		pF
cteristics (Note 2)					
Delay Time	$V_{DD} = -10 \text{ V}, \qquad I_D = -1 \text{ A}, \\ V_{GS} = -4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$		15	27	ns
Rise Time			15	27	ns
Delay Time			210	336	ns
Fall Time			100	160	ns
e Charge	$V_{DS} = -10 V$, $I_D = -9.2 A$,		60	96	nC
rce Charge	$V_{GS} = -4.5 V$		7		nC
n Charge			13		nC
de Characteristics	and Maximum Ratings				
				-1.2	Α
Irce Diode Forward	$V_{GS} = 0 V$, $I_S = -1.2 A$ (Note 2)		-0.5	-1.2	V
	pacitance ransfer Capacitance cteristics (Note 2) Delay Time Rise Time Delay Time Fall Time Charge rce Charge n Charge Ode Characteristics Continuous Drain–Source rrce Diode Forward ion-to-case and case-to-ambient th the dy design while R _{BCA} is deter	ransconductance $V_{DS} = -5 \text{ V}$, $I_D = -9.2 \text{ A}$ eristicsacitance $V_{DS} = -10 \text{ V}$, $V_{GS} = 0 \text{ V}$,pacitancef = 1.0 MHzransfer Capacitance $V_{DD} = -10 \text{ V}$, $I_D = -1 \text{ A}$,Cteristics (Note 2) $V_{DD} = -10 \text{ V}$, $I_D = -1 \text{ A}$,Delay Time $V_{DS} = -4.5 \text{ V}$, $R_{GEN} = 6 \Omega$ Delay Time $V_{DS} = -10 \text{ V}$, $I_D = -9.2 \text{ A}$,Charge $V_{DS} = -10 \text{ V}$, $I_D = -9.2 \text{ A}$,rce Charge $V_{DS} = -10 \text{ V}$, $I_D = -9.2 \text{ A}$,rce Charge $V_{DS} = -4.5 \text{ V}$ n Charge $V_{GS} = -4.5 \text{ V}$ Deley Time $V_{GS} = -10 \text{ V}$, $I_D = -9.2 \text{ A}$,rce Charge $V_{CS} = -4.5 \text{ V}$ n Charge $V_{CS} = -10 \text{ V}$, $I_D = -9.2 \text{ A}$,rce Charge $V_{CS} = -4.5 \text{ V}$ n Charge $V_{CS} = -1.2 \text{ A}$,Note 2) $V_{CS} = 0 \text{ V}$, $I_S = -1.2 \text{ A}$,rce Diode Forward $V_{CS} = 0 \text{ V}$, $I_S = -1.2 \text{ A}$,	ransconductance $V_{DS} = -5 \text{ V}$, $I_D = -9.2 \text{ A}$ eristics acitance $V_{DS} = -10 \text{ V}$, $V_{GS} = 0 \text{ V}$, pacitance f = 1.0 MHz ransfer Capacitance $V_{DD} = -10 \text{ V}$, $I_D = -1 \text{ A}$, Cteristics (Note 2) $V_{DD} = -10 \text{ V}$, $I_D = -1 \text{ A}$, Delay Time $V_{DD} = -10 \text{ V}$, $I_D = -1 \text{ A}$, Rise Time $V_{GS} = -4.5 \text{ V}$, $R_{GEN} = 6 \Omega$ Delay Time $V_{DS} = -10 \text{ V}$, $I_D = -9.2 \text{ A}$, Yes $V_{DS} = -10 \text{ V}$, $I_D = -9.2 \text{ A}$, Oclarge $V_{DS} = -10 \text{ V}$, $I_D = -9.2 \text{ A}$, Yes $V_{GS} = -4.5 \text{ V}$ The Charge $V_{DS} = -10 \text{ V}$, $I_D = -9.2 \text{ A}$, Yes $V_{GS} = 0 \text{ V}$, $I_S = -1.2 \text{ A}$, Ode Characteristics and Maximum Ratings Continuous Drain–Source Diode Forward Current Tree Diode Forward $V_{GS} = 0 \text{ V}$, $I_S = -1.2 \text{ A}$, Not-to-case and case-to-ambient thermal resistance where the case thermal reference is defined there by design while $R_{\theta CA}$ is determined by the user's board design.	ransconductance $V_{DS} = -5 V$, $I_D = -9.2 A$ 54eristicsacitance $V_{DS} = -10 V$, $V_{GS} = 0 V$,5878pacitance $f = 1.0 \text{ MHz}$ 994ransfer Capacitance559cteristics (Note 2) $V_{DD} = -10 V$, $I_D = -1 A$,15Delay Time $V_{DD} = -10 V$, $I_D = -1 A$,15Delay Time $V_{GS} = -4.5 V$, $R_{GEN} = 6 \Omega$ 15Delay Time $V_{DS} = -10 V$, $I_D = -9.2 A$,60Time $V_{DS} = -10 V$, $I_D = -9.2 A$,60Charge $V_{GS} = -4.5 V$ 7n Charge $V_{GS} = -4.5 V$ 7n Charge $V_{GS} = 0 V$, $I_S = -1.2 A$ (Note 2)-0.5continuous Drain-Source Diode Forward Current13ode Characteristics and Maximum Ratings-0.5continuous Drain-Source Diode Forward Current-0.5ion-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the soliteed by design while R_{eCA} is determined by the user's board design.	ransconductance $V_{DS} = -5 \text{ V}$, $I_D = -9.2 \text{ A}$ 54eristicsacitance $V_{DS} = -10 \text{ V}$, $V_{GS} = 0 \text{ V}$, 5878 pacitance $f = 1.0 \text{ MHz}$ 994 ransfer Capacitance 559 cteristics (Note 2) $V_{DD} = -10 \text{ V}$, $I_D = -1 \text{ A}$, $15 27$ Delay Time $V_{DD} = -10 \text{ V}$, $I_D = -1 \text{ A}$, $15 27$ Delay Time $V_{GS} = -4.5 \text{ V}$, $R_{GEN} = 6 \Omega$ $15 27$ Delay Time $V_{DS} = -10 \text{ V}$, $I_D = -9.2 \text{ A}$, $60 96$ Charge $V_{DS} = -10 \text{ V}$, $I_D = -9.2 \text{ A}$, $60 96$ \circ Charge $V_{DS} = -10 \text{ V}$, $I_D = -9.2 \text{ A}$, $7 100 160$ \circ Charge $V_{DS} = -10 \text{ V}$, $I_D = -9.2 \text{ A}$, $7 13$ \circ Charge $V_{DS} = 0 \text{ V}$, $I_S = -1.2 \text{ A}$, $7 13$ \circ Charge $V_{GS} = 0 \text{ V}$, $I_S = -1.2 \text{ A}$ (Note 2) $-0.5 -1.2$ \circ continuous Drain-Source Diode Forward Current -1.2 $-0.5 -1.2$ \circ ion-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mountilited by design while R_{eCA} is determined by the user's board design.





FDW254P Rev. C (W)



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